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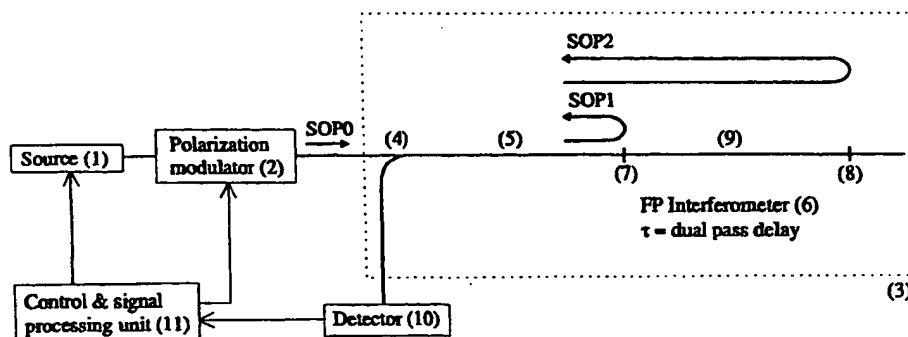
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(54) Title: ELIMINATION OF POLARIZATION FADING IN UNBALANCED OPTICAL MEASURING INTERFEROMETERS



(57) Abstract: Method and assembly for sustained elimination or reduction of polarization induced signal fading in optical inter-  
ferometer networks comprising at least two optical paths from an input port to an output port, the transmission delays of the paths  
differing by  $\tau$ , an interrogation arrangement interrogating the optical phase differences between the paths, containing at least one  
optical source launching optical power into a port, a detector arrangement converting the optical power from an output port into  
electrical detector signals, and a control and signal processing unit capable of processing detector signals to determine the phase  
difference. The method comprising the steps of: altering the input polarization state produced by the source with a modulation  
frequency that is comparable to or higher than  $1/(4\tau)$  receiving the optical signals at the detector arrangement providing a detector  
signal; processing the detector signal determining the phase difference between the optical signals.

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# ELIMINATION OF POLARIZATION FADING IN UNBALANCED OPTICAL MEASURING INTERFEROMETERS

This invention is related to a method and an assembly for the elimination of polarization fading in unbalanced optical measuring interferometers.

## BACKGROUND OF THE INVENTION

An optical interferometer is an optical transmission network that produces interference between different portions of optical radiation that have traveled different paths through the network. In an unbalanced optical interferometer the time delay in the two optical paths are different by an amount  $\tau$ . The output intensity from such an interferometer will have a periodic dependence called fringes of the output intensity that is periodic versus the interferometer phase delay  $\phi = 2\pi\nu\tau$ , where  $\nu$  is the optical frequency launched into the interferometer. Information about the path delay difference, the input optical frequency, or the input optical frequency spectrum may thus be deduced from the output interference signal.

An optical interferometer network may also contain more than one pair (or set) of paths from the input to the output port. Different pairs (or sets) of paths may then be interpreted as different interferometers. The interference caused by individual interferometers may be interrogated separately,

- a. by assigning a specific range of optical wavelengths, thus employing a wavelength division multiplexing (WDM) technique,
- b. by assigning a specific range of total transmission time delay to the paths associated with each interferometer, thus employing a time division multiplexing (TDM) technique,
- c. or by assigning a specific combination of input and output ports to the paths associated with each interferometer, thus employing a space division multiplexing (SDM) technique. An SDM system may for instance be interrogated by using optical switches to

access different combinations of input and output ports sequentially, or by splitting the optical radiation from a single interrogation source into different interferometer sub-networks, and connecting one  
5 detector to the output of each sub-network.

Network interrogation employing combinations of WDM, TDM and SDM is also possible.

The visibility or amplitude of the output fringes depends on the states of polarization (SOPs) of the two  
10 interfering signals, which we will label SOP1 and SOP2. In many interferometers SOP1 and SOP2 will vary randomly with time due to changes in the input SOP or in the birefringence properties of the two optical pathways. The fringe  
visibility is proportional to the projection of SOP1 onto  
15 SOP2. The reduction of fringe visibility with reduced projection of the SOPs is called polarization fading, and generally causes a reduced signal to noise ratio in the interferometer readout. Especially, the situation with SOP1  
⊥ SOP2 (orthogonal SOPs) causing total polarization fading  
20 with zero visibility should be avoided. When the fading is total, the interferometer output will not carry any information about  $v$  or  $t$  at all.

Several methods for reduction or elimination of the polarization fading problem are known. One known method uses  
25 Faraday rotating mirrors, as disclosed by A.D. Kersey et. al. in ["Polarisation insensitive fibre optic Michelson interferometer", El. Lett., Vol. 27, pp. 518-19, 1991]. This method allows for a simple source and detection system, but it works only for the Michelson interferometer  
30 configuration. Furthermore, the Faraday rotating mirrors may be expensive, space consuming, and sensitive to extreme thermal, electromagnetic and other environmental conditions.

Other known methods are based on active polarization control at the input, as disclosed by A. D. Kersey et. al.  
35 in ["Optimization and Stabilization of Visibility in Interferometric Fiber-Optic Sensors Using Input-Polarization Control", J. of Lightwave Technol., Vol. 6, pp. 1599-1609, 1988], or the use of a polarizer combined with active polarization control at the output end, as disclosed by K.

H. Wanser et. al. in ["Remote polarization control for fiber-optic interferometers ", Opt. Lett., Vol. 12, pp. 217-19, 1987]. In both cases the polarization controller is continuously adjusted to optimize the fringe visibility.

- 5 These techniques require relatively complex systems to provide feedback signals to the polarization controller, and in systems with spatial division multiplexing (SDM) or wavelength division multiplexing (WDM) of multiple sensors, individual polarization controllers for each sensor are
- 10 generally required. The polarization modulator used for the polarization control must be capable of modulating the SOP in three dimensions on the Poincarè sphere. This generally implies that the polarization modulators at least must be of the "dual stage" type. Dual stage polarization modulators
- 15 generally incorporate two independently adjustable birefringent elements, and are thus more complex and expensive than single stage modulators having only one adjustable birefringent element.

- Still other known methods are based on modulating the
- 20 input SOP between three states, as disclosed by A. D. Kersey et. al. in ["Input polarisation scanning technique for overcoming polarisation-induced signal fading in interferometric fiber sensors ", El. Lett., Vol. 24, pp. 931-33, 1988] and in [US Patent No. 4 932 783], or on the
- 25 use of three detectors at the output with three polarizers that are adjusted to monitor different polarization states, as disclosed by N. J. Frigo et. al. in ["Technique for elimination of polarisation fading in fibre interferometers", El. Lett., Vol. 20, pp. 319-20, 1984].
- 30 These techniques increase the complexity of the processing by requiring simultaneous processing of three fringe signals, especially in WDM systems where separate receivers are required for each WDM channel. They also increase the complexity of the hardware by either requiring a dual stage
- 35 polarization modulator, or three detectors and polarizers.

Another known method is based on the use of a pulsed source and a compensating interferometer which incorporates a polarization maintaining coupler, a standard coupler, and a polarization modulator, as disclosed by B. Y. Kim et. al.

in [US Patent No. 5 173 743]. This method may be attractive when applied to time division multiplexed (TDM) ladder sensor networks. However, the compensating interferometer increases the complexity of the interrogation, and 3 dB of source power is lost in the output coupler from the compensating interferometer. If the network is not of the ladder type, another 3 dB of optical power will be effectively lost at the detector, since only one half of the detected pulses will carry useful information. Another problem with this method is that the readout phase from the interferometer is sensitive to birefringence changes in the lead fiber between the source and the interferometers.

One sensor configuration of special interest is that of a WDM fiber-optic interferometric sensor system employing two identical wavelength selective low reflectivity fiber Bragg grating reflectors to define the two paths of each sensor interferometer. For instance, a Fabry-Perot interferometer can be formed by writing two identical Bragg gratings into the core of a single optical fiber at different locations. Different reflection bands should be dedicated to each sensor, so that information about the individual sensors can be accessed by use of a multi-wavelength source at the network input producing coherent light at each sensor wavelength, and a wavelength division multiplexer at the network output, that directs the interference signal from each sensor to a dedicated detector.

#### OBJECTIVE

The main objective of the present invention is to provide a simple and practical method and assembly, with reduced complexity compared to existing techniques, which eliminates or reduces the probability for polarization induced fading in optical interferometers. This objective implies that the output signals from the interferometer always should carry the information required to determine the difference in optical path length, or optical phase, between two different paths through the interferometer.

A second objective of the present invention is to

provide a method and assembly which allows the readout interferometer phase to be insensitive to birefringence changes in the lead fiber between the source and the interferometer.

5 A third objective of the present invention is to provide a method and assembly which can be applied to interrogation of any types of unbalanced interferometer that do not contain polarization selective components, such as polarizers or polarization beam splitters. This class of  
10 interferometers includes variants of the Fabry-Perot, Michelson, and Mach-Zender topologies. The method should also be applicable in interrogation systems where a pulsed source and a compensating interferometer is used to compensate out the imbalance of the interrogated  
15 interferometer(s).

A fourth objective of the present invention is to provide a method and assembly which can be applied to interrogation of wavelength division multiplexed (WDM), space division multiplexed (SDM), and time division  
20 multiplexed (TDM) interferometer networks, including TDM ladder networks.

A specific objective of the present invention is to provide a method and assembly which can be applied to interrogation of fiber optic wavelength division multiplexed  
25 sensor systems employing wavelength selective Bragg reflectors in the sensing interferometers and a multi-wavelength source, which requires only one polarization modulator for the entire system, and only one detector dedicated to the monitoring of each sensor.

30 A general objective of the present invention is to provide a method and assembly that overcomes limitations set by other known methods.

#### SUMMARY OF THE INVENTION

The objective of the invention is achieved with a  
35 method having features as stated in claims 1 and 8. Further features are stated in the dependent claims.

The main part of the invention is characterized in that the polarization state of the optical power launched into an

interferometer network is modulated at a frequency comparable to or higher than the inverse of the difference in transmission time delay between the two optical paths through the interferometer. A control and signal processing unit extracts several interference signals detected at the output of the interferometer network in at least two time slots, that are positioned in time at certain time delays (or phases) relative to the input polarization modulation period. The time slots should be chosen such that the two optical signals interfering at the output port after having traveled the two paths through the interferometer, originate from different combinations of input polarization states in each time slot, and such that total polarization fading of the interference visibility never will occur simultaneously in all time slots. Minimization of the sensitivity of the readout interferometer phase to birefringence changes in the path from the interrogating optical source to the interferometer may be achieved by modulating the input polarization between two orthogonal polarization states and by processing signals from four distinct time slots.

#### DETAILED DESCRIPTION OF THE INVENTION

The invention will be described below with reference to the accompanying drawings illustrating the invention by way of examples.

- Fig. 1 illustrates a preferred embodiment of this invention, including the interrogated interferometer network (3) including a Fabry-Perot interferometer.
- Fig. 2 illustrates a typical evolution of the input and output states of polarizations (SOPs) versus time.
- Fig. 3 illustrates alternative embodiments of the interferometer network (3) in Fig. 1, incorporating a Michelson interferometer in Fig. 3 (a) and a Mach-Zender interferometer in Fig. 3 (b).
- Fig. 4 illustrates an alternative embodiment of the invention, demonstrating interrogation of multiple wavelength division multiplexed interferometers.

In the preferred embodiment of this invention, illustrated in Fig. 1, an optical source (1) launches coherent optical radiation into the fiber-optic sensor network (3) through a polarization modulator (2). The sensor network (3) consists of an input-output optical coupler (4) with a 50% power splitting ratio, a lead fiber (5) and a low finesse Fabry-Perot (FP) interferometer (6) consisting of two reflectors (7,8) and a fiber delay line (9) with dual-pass delay  $\tau$ . The power reflectivities of (7) and (8) should preferably be small ( $<10\%$ ), allowing multiple mirror reflections to be neglected. The output power from the network (3) is guided to a photo-detector, and the resulting analog electrical signal is transferred to the analog-to-digital conversion interface of a control & signal processing unit (11), which is responsible for processing the detected signals electronically to extract the interferometer phase information, and for transferring this information in a suitable form to the end user.

The control & signal processing unit (11) also controls the polarization modulator (2) and causes the input polarization state SOP0 launched into (3) to switch between two orthogonal states, denoted SOP0a and SOP0b in Fig. 2. The polarization switching period should equal  $4\tau$ , and the duty-cycle of the modulation should be 50%, as illustrated by the top curve in Fig. 2. The coupler (4), the lead fiber (5), the interferometer fiber (9), and the reflectors (7,8) should have negligible polarization dependent losses. The latter condition implies that the polarization states SOP1 and SOP2 reflected from (7) and (8), respectively, and interfering at the left hand side of (7) in Fig. 1, will also both be switching between two orthogonal states, denoted SOP1A, SOP1B, SOP2A, and SOP2B in Fig. 2. SOP1A and SOP1B may then generally be written in a Jones-vector notation as

$$SPO1A = \vec{A} = K_1 \begin{bmatrix} \cos(\alpha) \\ \sin(\alpha) e^{i\gamma} \end{bmatrix} \quad SPO1B = \vec{B} = K_1 \begin{bmatrix} \cos(\alpha) e^{-i\gamma} \\ \sin(\alpha) \end{bmatrix}$$



where the vector elements are chosen to represent the projections of the fields onto the orthogonal eigen-polarization states of the interferometer. By the interferometer eigen-polarization states we mean the orthogonal output SOPs generated when the SOP0 is adjusted so that SOP1 = SOP2.  $K_1$  depends on the source power, and the losses in the transmission through (4,5,9) and in the reflections (7,8), while  $\alpha$  and  $\gamma$  are angles that depend on the birefringence properties of the lead fiber (5).

The chosen polarization projection states allow SOP2A and SOP2B to be written on the form

$$SPO2A = \mathbf{J}\bar{\mathbf{A}} = K_2 e^{i\phi} \begin{bmatrix} \cos(\alpha) \\ \sin(\alpha) e^{i\gamma+\theta} \end{bmatrix} \quad SPO2B = \mathbf{J}\bar{\mathbf{B}} = K_2 e^{i\phi} \begin{bmatrix} \cos(\alpha) e^{-i\gamma} \\ \sin(\alpha) e^{i\theta} \end{bmatrix}$$

where the Jones matrix

$$\mathbf{J} = e^{i\phi} \begin{bmatrix} 1 & 0 \\ 0 & e^{i\theta} \end{bmatrix} \quad (1)$$

essentially describes difference between the SOP changes from SOP0 to SOP1 and that from SOP0 to SOP2.  $\phi = 2\pi\nu\tau$  is the interferometer phase that we want to measure,  $\nu$  is the optical frequency, and  $\theta$  is the birefringent phase-shift between the eigen-polarization states of the interferometer.  $K_2$  depends on losses in the transmissions and reflections of the system.

The two lower curves in Fig. 2 illustrate the switching of SOP1 and SOP2. A periodic pattern consisting of 4 time slots can be observed, where:

- SOP1A interferes with SOP2A in slot1,
- SOP1B interferes with SOP2A in slot2,
- SOP1B interferes with SOP2B in slot3,
- SOP1A interferes with SOP2B in slot4.

The interference power will be composed by one term that depends on  $\phi, \theta, \gamma$ , and  $\alpha$ , and one term that is independent on

these parameters. The power from each time slot  $n$  will produce an electrical signal  $S_n$  at the detector output, which is proportional to the interference power. Based on the given conditions, it can be shown that

$$\begin{aligned} S_1 &= 2K_3 \operatorname{Re}\{\vec{A}^* \vec{J}\vec{A}\} = a \cos(\phi_1) \\ S_2 &= 2K_3 \operatorname{Re}\{\vec{B}^* \vec{J}\vec{A}\} = a \cos(\phi_2) \\ S_3 &= 2K_3 \operatorname{Re}\{\vec{B}^* \vec{J}\vec{B}\} = a \cos(\phi_3) \\ S_4 &= 2K_3 \operatorname{Re}\{\vec{A}^* \vec{J}\vec{B}\} = a \cos(\phi_4) \end{aligned} \quad (2)$$

5 where  $K_3$  accounts for the detector responsivity and losses in (4,5), superscript  $*$  indicates conjugate transpose,

$$\begin{aligned} \phi_1 &= \phi + \theta + \varphi \\ \phi_2 &= \phi + \theta/2 + \gamma - \pi/2 \\ \phi_3 &= \phi - \theta \\ \phi_4 &= \phi + \theta/2 - \gamma - \pi/2 \end{aligned} \quad , \text{ and } a^2 + b^2 = K_1 K_2 K_3^2. \quad (3)$$

$\varphi$  is a function of  $\theta$  and  $\alpha$ .

The control & processing unit extracts the signals  $S_1$  through  $S_4$  and processes them to determine the phases  $\phi_1$  through  $\phi_4$ . Note that the detected signals are delayed relative to the control signals supplied to the polarization modulator. Some calibration of the input slot timing is therefore required. Several methods are known for phase reconstruction without ambiguity from interference signals, as disclosed for instance by I. J. Bush in ["High performance interferometric demodulation techniques", SPIE Proc., Vol. 1795, pp. 412-20, 1992]. Generally, these methods require means for modulating the interference phase to generate in-phase and quadrature information from the interference fringes. In the preferred embodiment of the present invention this can be achieved by modulating the phase of the source radiation at a frequency that is an odd harmonic of  $1/(4\tau)$ .

We see from (Eq. 2) that the detected fringe amplitudes equal  $a$  in slots 1 and 3, and  $b$  in slots 2 and 4. Since  $a^2 + b^2 = K_1 K_2 K_3^2$  according to (Eq. 3), there can never be fading

simultaneously in two neighboring time slots, and the sum of the signal to noise ratios of two neighboring time slots, limited by the fringe amplitude, will be independent on the birefringence parameters  $\theta, \gamma$ , and  $\alpha$ . Thus, the main objective of the present invention is satisfied.

It remains to combine the information carried by  $\phi_1, \phi_2, \phi_3$ , and  $\phi_4$  into one single estimate for the interferometer phase delay, which according to (Eq. 1) is  $\phi$  for one eigen-polarization and  $\phi+\theta$  for the other eigen-polarization. In the preferred embodiment, the estimator

$$\Phi = \frac{a^2(\phi_1 + \phi_2) + b^2(\phi_3 + \phi_4)}{a^2 + b^2} \quad (4)$$

is computed by the control & processing unit to estimate the interferometer phase delay. By combining (Eq. 3) and (Eq. 4) we see that  $\Phi$  in the absence of noise equals  $\phi+\theta/2$ , which is exactly the mean of the two eigen-polarization phase delays.  $\Phi$  is independent on the birefringence parameters  $\gamma$  and  $\alpha$  of the lead fiber, and thus the second objective of the present invention is satisfied. The weighting in (Eq. 4) of  $\phi_1+\phi_2$  and  $\phi_3+\phi_4$  by  $a^2$  and  $b^2$ , respectively, ensures that the signal to noise ratio of the estimator always will be close to a maximum.

The present invention may be implemented for interrogation of any types of unbalanced interferometer networks that do not contain polarization selective components such as polarizers or polarization beam splitters. As one example, Fig. 3 (a) illustrates a network incorporating a Michelson interferometer, which may replace the network (3) in Fig. 1 in a second embodiment of the present invention. SOP0 is launched into the input/output coupler (4) and the lead fiber (5), having the same functions as in Fig. (1). The Michelson interferometer (12) is formed by an optical coupler (13) splitting the optical power from (5) into two delay arms, with reflectors (14,15) positioned at different distances from (13) so that the dual path time delays experienced by the two reflected signals

recombined in (13) differ by  $\tau$ . SOP1 and SOP2 in this case refer to the polarization states recombined in (13) after returning from the short delay arm with reflector (14) and the long delay arm with reflector (15), respectively.

5 As another example, Fig. 3 (b) illustrates a network incorporating a Mach-Zender (MZ) interferometer, which may replace the network (3) in Fig. 1 in a third embodiment of the present invention. This system has separate input (16) and output (22) lead fibers. SOP0 is launched into (16). The  
10 MZ interferometer (17) is formed by an optical coupler (18) splitting the optical power from (16) into two delay arms (19,20). The signals emerging from (19) and (20) are combined in a second optical coupler (21). The single pass time delays between (18) and (21) through (19) and (20)  
15 should differ by  $\tau$ . SOP1 and SOP2 in this case refer to the polarization states entering (21) from the short (19) and long (20) arms, respectively.

Fig. 4 illustrates a fourth embodiment of the present invention capable of wavelength division multiplexing of  
20 several wavelength selective interferometers. In the illustrated example, a multi-wavelength source (23) is used, launching coherent radiation at three sensor interrogation wavelengths  $\lambda_1$ ,  $\lambda_2$ , and  $\lambda_3$  through the polarization modulator (2) into the interferometer network (24). The input  
25 polarization of all wavelengths is switched simultaneously between orthogonal states, in the same way as explained for SOP0 in the preferred fifth embodiment of the present invention. The network contains an input/output coupler (4), a lead fiber (5) and three FP-interferometers with  
30 approximately equal dual-pass delay  $\tau$ . Each FP-interferometer consists of two identical Bragg gratings, denoted (25), (26) or (27), causing a weak reflection in a narrow band around the respective sensor interrogation wavelength  $\lambda_1$ ,  $\lambda_2$ , or  $\lambda_3$ . Each sensor grating pair should  
35 produce negligible reflections at the interrogation wavelengths of the other sensors. A wavelength division demultiplexer (28) is connected to the output branch of (4), distributing the interference signals from the different

interferometers to different detectors (29, 30, 31). The control & processing unit (32) processes the three detector signal sequences in parallel in the same way as explained for the single processing channel in the first preferred embodiment, to extract the individual interference phases of the three interferometers and present this information for the end user.

The network (23) in Fig. 4 can be interrogated by a time division multiplexing (TDM) approach using the present invention, provided that all reflectors reflect the same wavelength, i.e. either  $\lambda_1 = \lambda_2 = \lambda_3$ , or the gratings must be replaced with broad-banded reflectors, and that the dual pass delays from the input/output (4) to the beginning of the different interferometers all are separated by at least in the order of  $3\tau$ . In this case, a possible fifth embodiment of the present invention uses a pulsed single wavelength source at wavelength  $\lambda_1$ , and only one detector without any wavelength demultiplexer in front, like the detector (10) in Fig. 1. The source and polarization modulator produces pulses with a duration of minimum  $2\tau$ , with polarization state switching between orthogonal polarizations within each pulse at a frequency that is an odd harmonic (or multiple) of  $1/(4\tau)$  and which is higher than the inverse pulse duration, like illustrated for SOP0 in Fig. 2. The detected signal will consist of one time sequence for each pulse transmitted from the source, each sequence containing at least four time-slots originating from each sensor interferometer. The time slots contain information about the interference phases of individual sensors, encoded in the same way as for the output time-slot signals described in the first preferred embodiment. The control and processing unit may thus extract the interference phases by separating, identifying and processing the information originating from each sensor in the same way as described for the first preferred embodiment.

A special case of TDM interferometer networks are ladder interferometer networks, with geometries of the type

described in [US Patent No. 5 173 743, Fig.1, items (26), (27 a, b, c, d), (28), and (31 a, b, c, d)]. In the ladder networks, the input to output delay of a number  $N$  of interferometer arms are equally spaced by the amount  $\tau$ , and  
5 all paths, except for two, are thus part of two interferometers at the same time. The current invention can be used for interrogation of such ladder networks, including a compensating interferometer with imbalance  $\tau$  placed after the source, as illustrated in [US Patent No. 5  
10 173 743, Fig.1, items (20, 21, 22, 23, 25)]. Each pulse from the source should have duration equal to  $\tau$ , and will thus be split into two by the compensating interferometer. The polarization modulator can be placed between the compensating interferometer and the network. Polarization  
15 maintaining fibers and couplers should be used in the compensating interferometer to ensure that the polarization states of the two consecutive pulses emerging from the compensating interferometer will be switching between identical pairs of orthogonal polarization states.  
20 Alternatively, an imbalanced Michelson interferometer with Faraday-rotating mirrors, and otherwise standard fibers and couplers, may be used as the compensating interferometer.

The current invention may be used for interrogation of such ladder networks, without the inclusion of any  
25 compensating interferometer. The duration of each pulse from the source should in this case be close to  $2\tau$ .

Although coherent sources have been assumed in all the previous examples, the present invention can also be used in a white-light interferometer that are interrogated by  
30 scanning the path-imbalance of a compensating interferometer.

## C l a i m s

1. Method for sustained elimination or reduction of polarization induced signal fading in optical interferometer networks comprising

at least two optical paths from an input port to an output port, the transmission delays of the at least two paths differing by an amount of time  $\tau$ ,

an interrogation arrangement interrogating the optical phase differences induced between optical waves having traveled the said paths,

said arrangement containing at least one optical source launching optical power into said input port, a detector arrangement converting the optical power received from said output port into electrical detector signals, and a control and signal processing unit capable of processing said detector signals to determine the said phase difference,

the method comprising the steps of:

- altering the input polarization state produced by the source with a modulation frequency that is comparable to or higher than  $1/(4\tau)$ ,
- receiving the at least two optical signals having traveled said at least two paths at said detector arrangement providing a detector signal,
- processing said detector signal at said control and signal processing unit determining the phase difference between the optical signals having traveled said paths.

2. Method according to claim 1, in which the input polarization state produced by the source changes between a first and a second state (SOP0A, SOP0B), and in which four interference signals (i, ii, iii, iv) being separated in time, representing interference between polarization states at said output port that originate from the transmission of

- (i) SOP0A through both the first and the second interferometer path,
- (ii) SOP0B through the first and SOP0A through the

second interferometer path,  
(iii) SOP0B through both interferometer paths, and  
(iv) SOP0A through the first and SOP0B through the  
second interferometer path,  
respectively, are extracted by said control and signal  
processing unit and further processed to produce estimates  
for the interference phases of the four interference  
signals (i,ii,iii,iv).

3. Method according to claim 2, wherein the interference  
visibilities or fringe amplitudes of the four interference  
signals (i,ii,iii,iv) are calculated.

4. A method according to claim 3, wherein SOP0A and SOP0B  
are orthogonal polarization states, and a first improved  
phase estimate, called  $\Phi_1$ , is calculated as the average of  
the two said interference phase estimates produced from (i)  
and (iii), and a second improved phase estimate, called  $\Phi_2$ ,  
is calculated as the average of the two said interference  
phase estimates produced from (ii) and (iv), and a combined  
phase estimate is calculated as a weighted average of  $\Phi_1$  and  
 $\Phi_2$ , where the ratio between the weighting of  $\Phi_1$  and the  
weighting of  $\Phi_2$  is decided from the relation between the  
said interference visibilities or fringe amplitudes.

5. Use of a method according to claims 1, 2, 3, or 4,  
wherein the method is applied to interrogate a wavelength  
division multiplexed interferometer network.

6. Use of a method according to claims 1, 2, 3, or 4,  
wherein the method is applied to interrogate a time division  
multiplexed interferometer network.

7. Use of a method according to claims 1, 2, 3, or 4,  
wherein the method is applied to interrogate space division  
multiplexed interferometer networks.



8. Assembly for sustained elimination or reduction of polarization induced signal fading in optical interferometer networks comprising:

at least two optical paths from an input port to an output port, the transmission delays of the at least two paths differing by an amount of time  $\tau$ ,

an interrogation arrangement interrogating the optical phase differences induced between optical waves having traveled the said paths,

said arrangement containing at least one optical source launching optical power into said input port, a detector arrangement converting the optical power received from said output port into electrical detector signals, and a control and signal processing unit capable of processing said detector signals to determine the said phase difference,

said optical source comprising polarization means for altering the input polarization state produced by the source with a modulation frequency that is comparable to or higher than  $1/(4\tau)$ ,

9. Assembly according to claim 8, wherein the input polarization state produced by the source is adapted to emit alternately a first and a second state (SOP0A, SOP0B) through two interferometer paths resulting in four interference signals (i, ii, iii, iv) being separated in time, representing interference between polarization states at said output port originating from the transmission of

- (i) SOP0A through both the first and the second interferometer path,
- (ii) SOP0B through the first and SOP0A through the second interferometer path,
- (iii) SOP0B through both interferometer paths, and
- (iv) SOP0A through the first and SOP0B through the second interferometer path,

respectively, said control and signal processing unit being adapted to extract and further process said interference

signals to produce estimates for the interference phases, visibilities and/or fringe amplitudes of the four interference signals (i,ii,iii,iv).

10. Assembly according to claim 9, wherein SOP0A and SOP0B are orthogonal polarization states, and a first improved phase estimate, called  $\Phi_1$ , is calculated as the average of the two said interference phase estimates produced from (i) and (iii), and a second improved phase estimate, called  $\Phi_2$ , is calculated as the average of the two said interference phase estimates produced from (ii) and (iv), and a combined phase estimate is calculated as a weighted average of  $\Phi_1$  and  $\Phi_2$ , where the ratio between the weighting of  $\Phi_1$  and the weighting of  $\Phi_2$  is decided from the relation between the said interference visibilities or fringe amplitudes.

11. Assembly according to claim 8, wherein said at least two optical paths are constituted by a fiberoptic Michelson interferometer.

12. Assembly according to claim 8, wherein said at least two optical paths are constituted by a fiberoptic Fabry-Perot interferometer.

13. Assembly according to claim 8, wherein said at least two optical paths are constituted by a fiberoptic Mach-Zender interferometer.

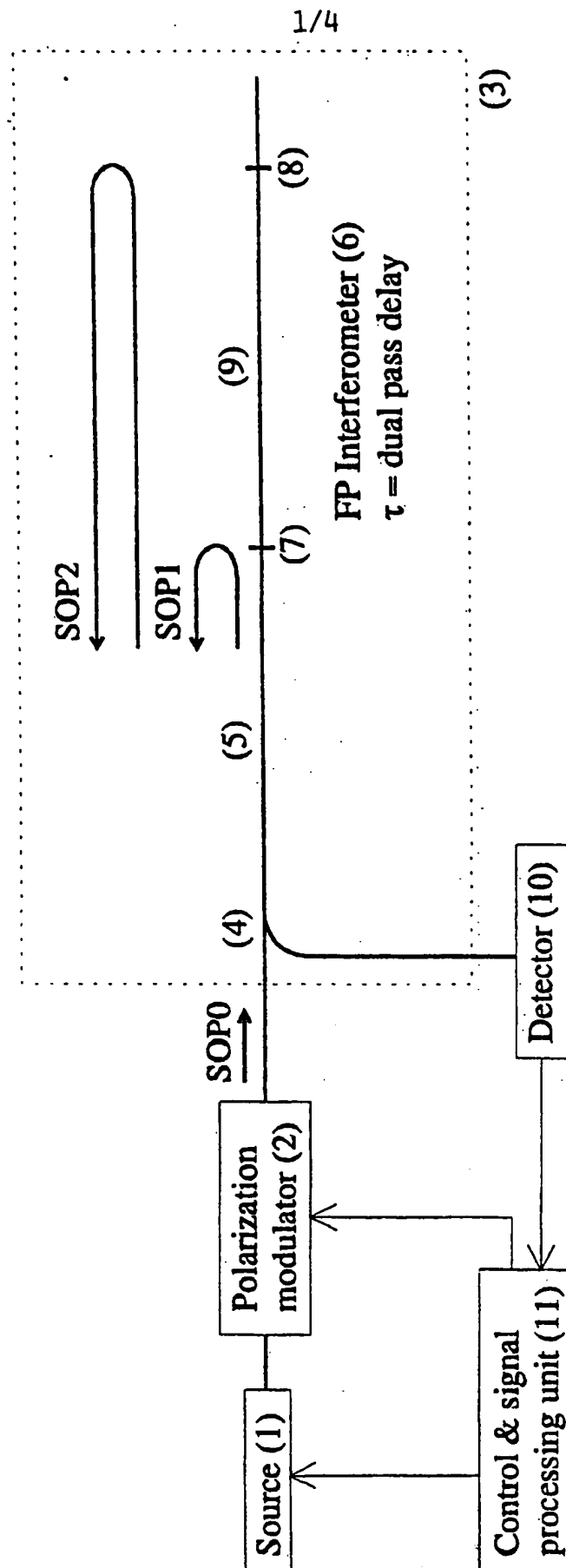


Fig. 1

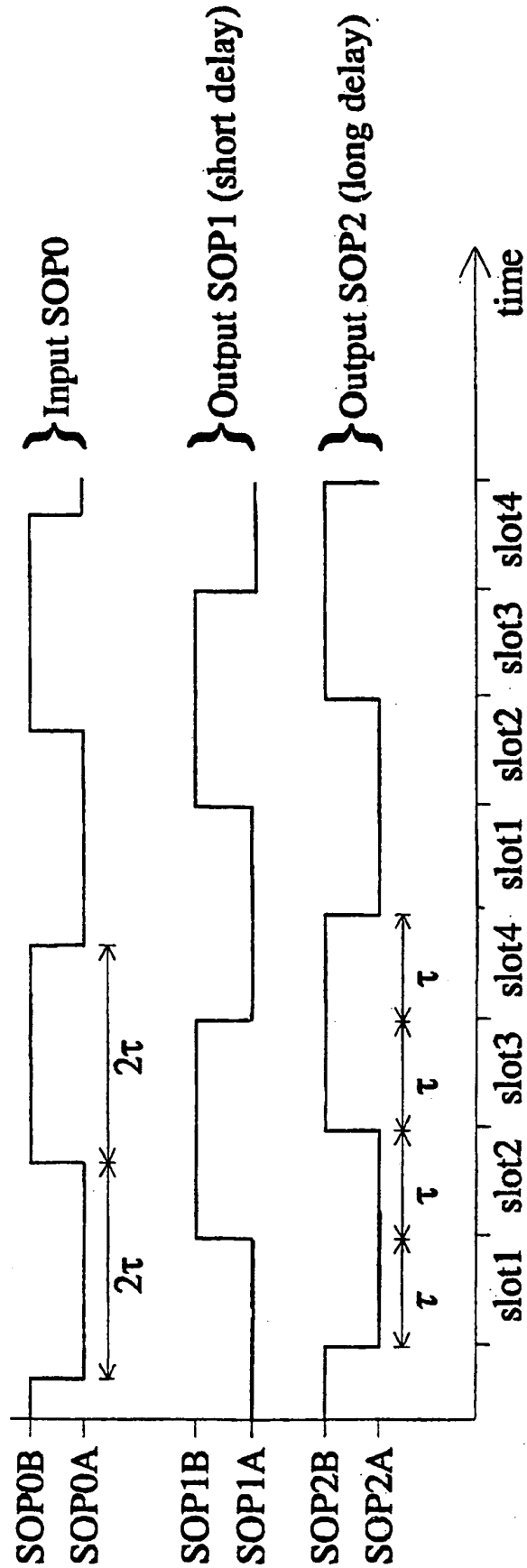


Fig. 2

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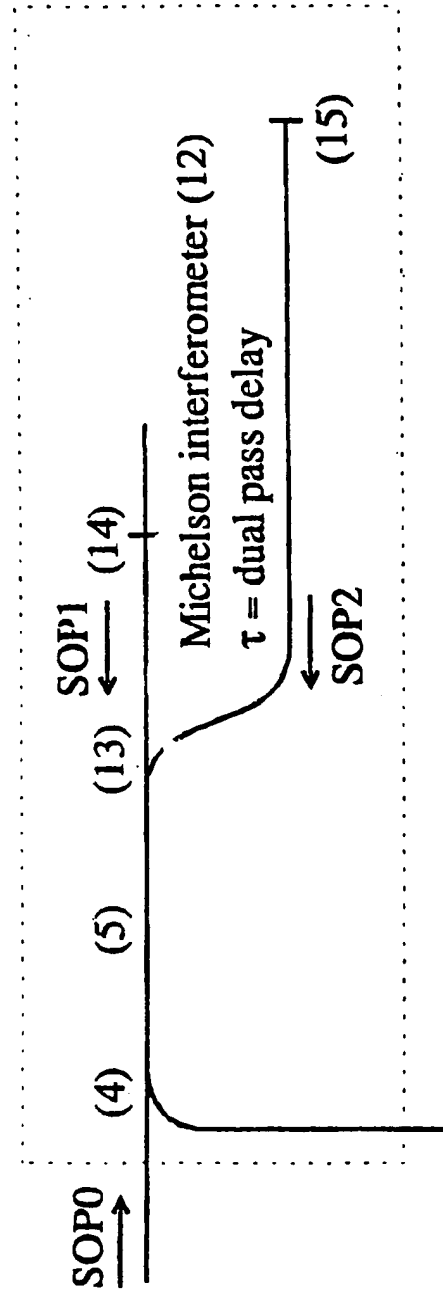


Fig. 3 (a)

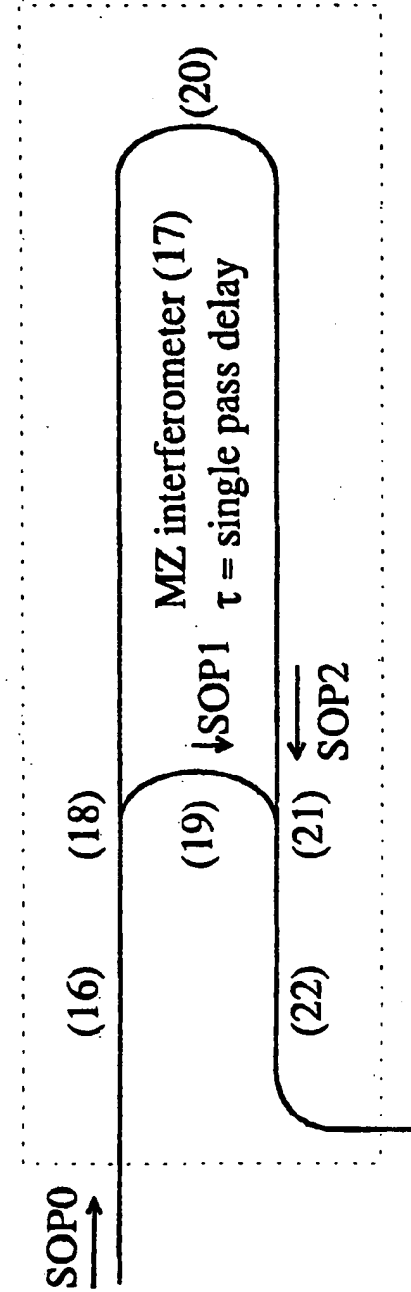


Fig. 3 (b)

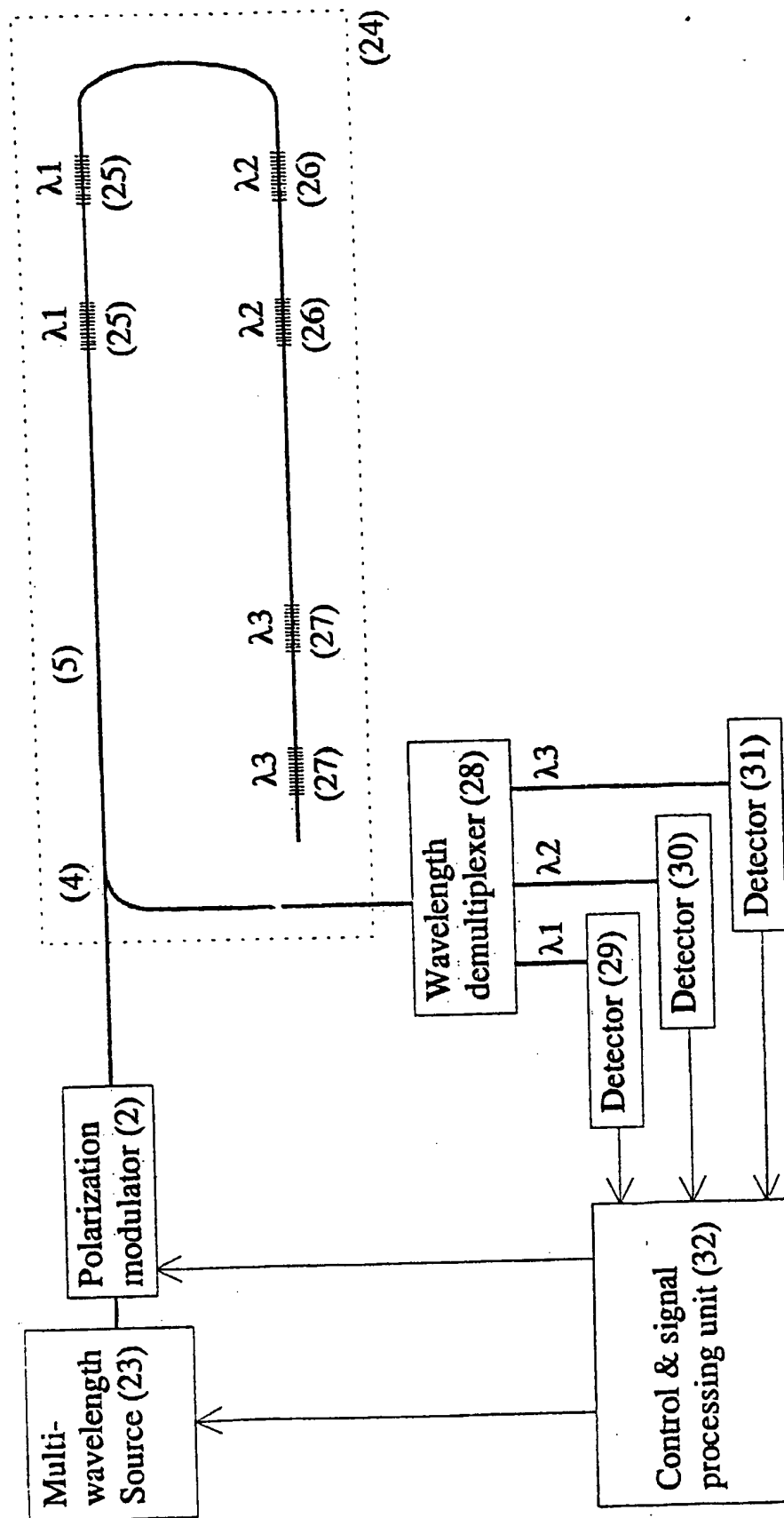


Fig. 4

## INTERNATIONAL SEARCH REPORT

International application No.

PCT/NO 00/00219

## A. CLASSIFICATION OF SUBJECT MATTER

IPC7: G02F 1/01

According to International Patent Classification (IPC) or to both national classification and IPC

## B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC7: G02F

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

SE,DK,FI,NO classes as above

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

## C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	US 5173743 A (B.Y.KIM), 22 December 1992 (22.12.92), figure 2, abstract --	1-13
A	US 5351124 A (LASKOSKIE ET AL), 27 Sept 1994 (27.09.94), figure 2B, abstract --	1-13
A	US 4897543 A (A.D.KERSEY), 30 January 1990 (30.01.90), figure 4, abstract -- -----	1-13

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Further documents are listed in the continuation of Box C.

☒

See patent family annex.

\* Special categories of cited documents:

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"&amp;" document member of the same patent family

Date of the actual completion of the international search

19 October 2000

Date of mailing of the international search report

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# INTERNATIONAL SEARCH REPORT

Information on patent family members

03/10/00

International application No.

PCT/NO 00/00219

Patent document cited in search report			Publication date	Patent family member(s)	Publication date
US	5173743	A	22/12/92	NONE	
US	5351124	A	27/09/94	NONE	
US	4897543	A	30/01/90	NONE	